Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/726,538	TANAKA, KAZUHIRO	
Examiner	Art Unit	
Eric Pico	3654	

	SEARCHED				
Class	Subclass	Date	Examiner		
187	264, 266, 413, 414	1/26/2006	EEP		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
Asv	DATE	EXMR		
Class 187 Consulted Thuy Tran	1/26/2006	EEP		
EAST Seach History Attached	1/26/2006	EEP		